

APPLICANT'S ART CITATION (Use several sheets if necessary)		Application		OFGS File No. P/4303-32			
		Applicant Simon FRANK et al.					
		Filing Date Herewith		Group Art Unit 3612			
U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
KBL	US-6,174,009 B1	1/2001	McKEON				
	US-5,876,077	3/1999	MISKECH et al.				
	US-3,842,222	10/1974	HOGLAND				
	US-3,897,095	7/1975	GLANCE et al.				
	US-3,912,295	10/1975	EGGERT, Jr.				
	US-3,998,485	12/1976	PUTTER et al.				
	US-4,023,652	5/1977	TORKE				
	US-4,272,114	6/1981	HIRANO et al.				
	US-4,413,856	11/1983	McMAHAN et al.				
	US-4,465,312	8/1984	WERNER				
	US-4,684,151	8/1987	DREWEK				
	US-5,078,439	1/1992	TERADA et al.				
	US-5,201,912	4/1993	TERADA et al.				
	US-5,314,229	5/1994	MATUZAWA et al.				
	US-5,403,049	4/1995	EBBINGHAUS				
	US-5,431,445	7/1995	WHEATLEY				
	US-5,732,801	3/1998	GERTZ				
	US-5,772,267	6/1998	HEIM et al.				
FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
KBL	546 352	6/1993	Europe				
	11-208393	8/1999	Japan				
	55-136660	10/1980	Japan				
	WO 98/39197	9/1998	PCT				
Examiner KBL		Date Considered 5-20-04					
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

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Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
<i>KBL</i>	US-5,853,195	12/1998	LE et al.				
	US-5,876,078	3/1999	MISKECH et al.				
	US-6,106,039	8/2000	MAKI				
	US-6,203,098	3/2001	MOTOZAWA et al.				
	US-6,152,521	11/2000	HAYASHI et al.				
	US-6,174,009	1/2001	McKEON				
	US-6,179,355	1/2001	CHOU et al.				
	US-6,227,582	5/2001	ICHIE				
	US-6,299,226	10/2001	KRONING et al.				
	US-2001/0013706	8/2001	ARTNER				
	US-						
	US-						
	US-						
	US-						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
<i>KBL</i>	2-175452	7/1990	Japan				
	19517921	11/1996	Germany				
	0854066	12/1997	Europe				
	19700022	7/1998	Germany				
	11-268663	10/1999	Japan				
	19913078	9/2000	Germany				
	2002-104107	4/2002	Japan				
Examiner <i>KBL</i>		Date Considered <i>5-26-04</i>					
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U. S. DEPARTMENT OF COMMERCE
Sheet 1 of 1

PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 4780-23
Serial No.: n/a
Applicant: Simon FRANK

Filing Date: concurrently

Group Art:

U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
KBO	AA	6,174,009 B1	01/16/2001	McKeon			
1	AB	5,876,077	03/02/1999	Miskech, et al.			
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
KBO	AF	546 352	06/16/1993	Europe				
	AG	11-208393	08/03/1999	Japan				
	AH	55-136660	10/24/1980	Japan				
	AI	WO 98/39197	09/11/1998	PCT				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AJ		
	AK		
	AL		

EXAMINER: KBO

DATE CONSIDERED: 5.26.04

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